

<b>Notice of References Cited</b>	Application/Control No. 10/760,447		Applicant(s)/Patent Under Reexamination DETTINGER ET AL.	
	Examiner Mitiku Debelie		Art Unit 2621	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0160308	07-2005	Elcock et al.	714/005
*	B	US-2002/0039483	04-2002	Frost et al.	386/109
*	C	US-7,088,910	08-2006	Potrebic et al.	386/83
*	D	US-2004/0237104	11-2004	Cooper et al.	725/038
*	E	US-2001/0052131	12-2001	Hobson et al.	725/105
*	F	US-2005/0120128	06-2005	Willes et al.	709/232
*	G	US-2004/0103215	05-2004	Ernst et al.	709/247
*	H	US-2005/0135779	06-2005	Garrison et al.	386/046
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.